

# STB13NK60ZT4, STP13NK60Z STP13NK60ZFP, STW13NK60Z

N-channel 600 V, 0.48 Ω, 13 A, TO-220, TO-220FP, D<sup>2</sup>PAK TO-247 Zener-protected SuperMESH<sup>™</sup> Power MOSFET

### Features

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	Pw
STB13NK60ZT4	600 V	<0.55 Ω	13 A	150 W
STP13NK60ZFP	600 V	<0.55 Ω	13 A	35 W
STP13NK60Z	600 V	<0.55 Ω	13 A	150 W
STW13NK60Z	600 V	<0.55 Ω	13 A	150 W

- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability

### Application

Switching applications

### Description

The SuperMESH<sup>™</sup> series is obtained through an extreme optimization of ST's well established strip-based PowerMESH<sup>™</sup> layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications.

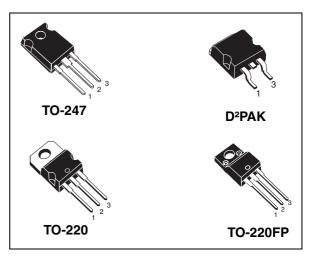
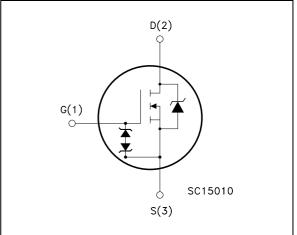


Figure 1. Internal schematic diagram



#### Table 1. Device summary

Order codes	Marking	Package	Packaging
STB13NK60ZT4	B13NK60Z	D <sup>2</sup> PAK	Tape and reel
STP13NK60ZFP	P13NK60ZFP	TO-220FP	Tube
STP13NK60Z	P13NK60Z	TO-220	Tube
STW13NK60Z	W13NK60Z	TO-247	Tube

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## 1 Electrical ratings

		Value		
Symbol	Parameter	TO-220 / TO-247 D²PAK	TO-220FP	Unit
V <sub>DS</sub>	Drain-source voltage ( $V_{GS} = 0$ )	600		V
V <sub>GS</sub>	Gate-source voltage	± 30		V
I <sub>D</sub>	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	13 13 <sup>(1)</sup>		А
۱ <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	8.2 8.2 <sup>(1)</sup>		А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	n current (pulsed) 52 52 <sup>(1)</sup>		А
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	150	) 35	
	Derating factor	1.20	0.27	W/°C
Vesd(G-S)	G-S ESD (HBM C=100pF, R=1.5 kΩ)	4000		V
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	4.5		V/ns
V <sub>ISO</sub>	Insulation withstand voltage (AC) 2500		V	
T <sub>j</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150		°C

#### Table 2.Absolute maximum ratings

1. Limited only by maximum temperature allowed

2. Pulse width limited by safe operating area

3.  $I_{SD} \leq$  13 A, di/dt  $\leq$  200 A/µs,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq T_{JMAX}$ 

#### Table 3. Thermal data

Symbol	Parameter	TO-220 TO-247	D <sup>2</sup> PAK	TO-220FP	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.83		3.6	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-pcb max		60		°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-amb max	62.5		°C/W	
Τ <sub>Ι</sub>	Maximum lead temperature for soldering purpose		300		°C

1. When mounted on minimum footprint



Symbol	Parameter	Max value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not- repetitive (pulse width limited by Tj max)	10	A
E <sub>AS</sub>	Single pulse avalanche energy (starting Tj=25 °C, I <sub>D</sub> =I <sub>AR</sub> , V <sub>DD</sub> = 50 V)	400	mJ

 Table 4.
 Avalanche characteristics



### 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	600			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max rating, $V_{DS}$ = Max rating,Tc=125 °C			1 50	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±20 V			±10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 100 \ \mu A$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.5 A		0.48	0.55	Ω

#### Figure 2. On/off states

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	V <sub>DS</sub> =8 V, I <sub>D</sub> = 5 A	-	11		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> =25 V, f=1 MHz, V <sub>GS</sub> =0	-	2030 210 48		pF pF pF
C <sub>oss eq.</sub> <sup>(2)</sup>	Equivalent output capacitance	$V_{GS}$ =0, $V_{DS}$ =0 to 480 V	-	125		pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ =480 V, $I_D$ = 10 A $V_{GS}$ =10 V (see Figure 21)	-	66 11 33	92	nC nC nC

1. Pulsed: pulse duration =  $300\mu s$ , duty cycle 1.5%

2.  $C_{oss~eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD}$ = 300 V, I <sub>D</sub> = 5 A, R <sub>G</sub> =4.7 $\Omega$ , V <sub>GS</sub> =10 V (see Figure 20)	-	22 14	-	ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off delay time Fall time	V <sub>DD</sub> =300 V, I <sub>D</sub> = 5 A, R <sub>G</sub> =4.7 Ω, V <sub>GS</sub> =10 V (see Figure 20)	-	61 12	-	ns ns
t <sub>r(Voff)</sub> t <sub>f</sub> t <sub>c</sub>	Off-voltage rise time Fall time Cross-over time	V <sub>DD</sub> =480 V, I <sub>D</sub> = 10 A, R <sub>G</sub> =4.7 Ω, V <sub>GS</sub> =10 V (see Figure 20)	-	10 9 20	-	ns ns ns

Table 6.Switching times

 Table 7.
 Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
BV <sub>GSO</sub>	Gate-source breakdown voltage	lgs=±1mA (open drain)	30	-	-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

Table 8. Sourc	e drain diode
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)		-		10 40	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 10 \text{ A}, V_{GS} = 0$	-		1.6	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> = 10 A, di/dt = 100 A/μs, V <sub>DD</sub> =35 V, Tj=150 °C	-	570 4.5 16		ns μC Α

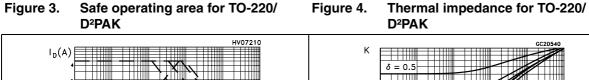
1. Pulse width limited by safe operating area

2. Pulsed: pulse duration =  $300\mu s$ , duty cycle 1.5%



GC20540

#### 2.1 **Electrical characteristics (curves)**



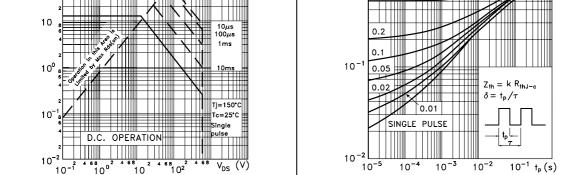
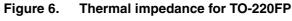


Figure 5. Safe operating area for TO-220FP



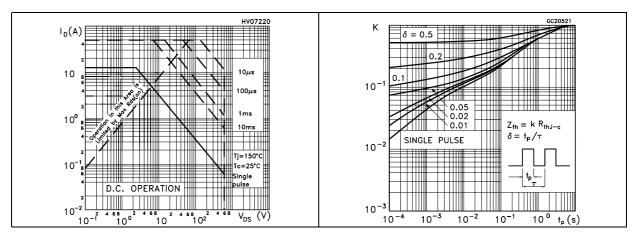
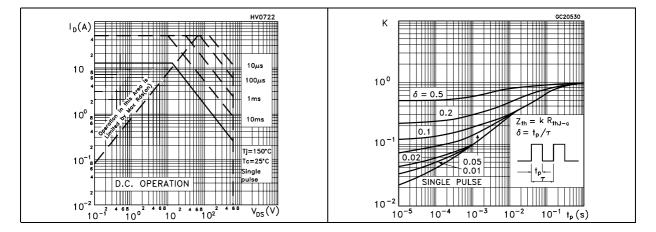


Figure 7. Safe operating area for TO-247

Figure 8. Thermal impedance for TO-247





6

HV07240

8 V<sub>GS</sub>(V)

Figure 10. Transfer characteristics

Vos=25V

2

4

Figure 12. Static drain-source on resistance

l₀(A)

20

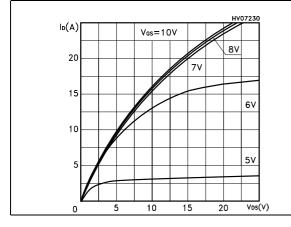
15

10

5

0

### Figure 9. Output characteristics



#### Figure 11. Transconductance

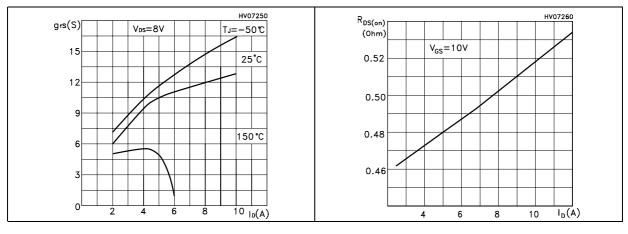
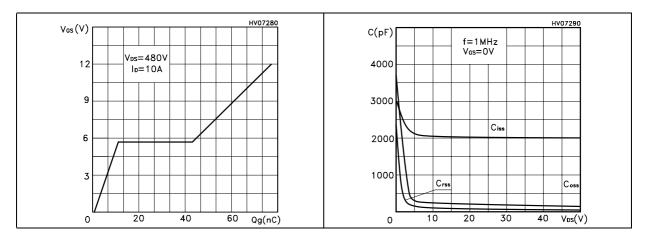


Figure 13. Gate charge vs gate-source voltage Figure 14. Capacitance variations



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# Figure 15. Normalized gate threshold voltage Figure 16. vs temperature

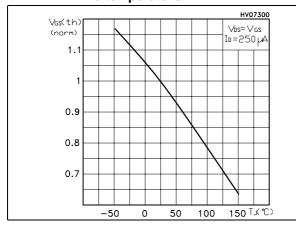


Figure 17. Source-drain diode forward characteristics

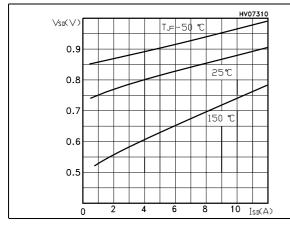
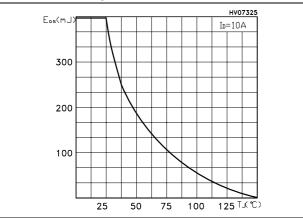


Figure 19. Maximum avalanche energy vs temperature



jure 16. Normalized on resistance vs temperature

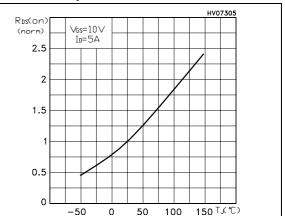


Figure 18. Normalized B<sub>VDSS</sub> vs temperature

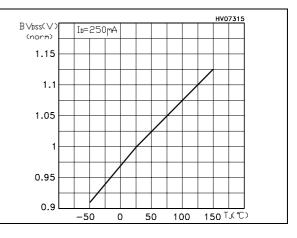
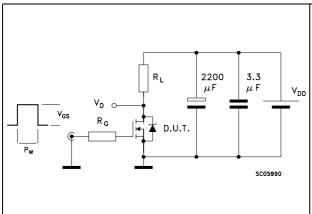




Figure 21. Gate charge test circuit

## 3 Test circuits

Figure 20. Switching times test circuit for resistive load



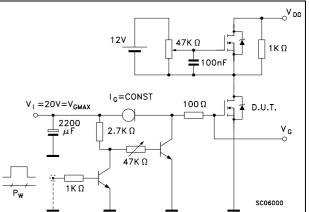
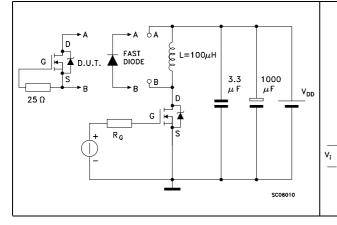
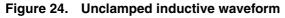
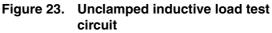
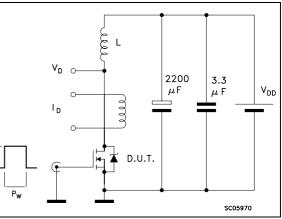


Figure 22. Test circuit for inductive load switching and diode recovery times

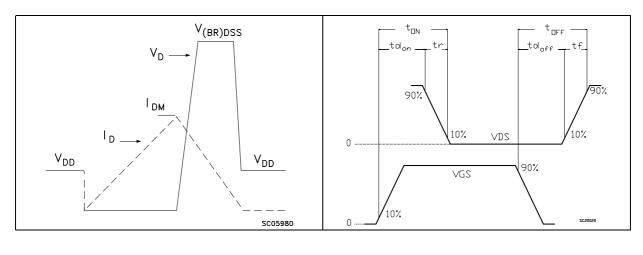












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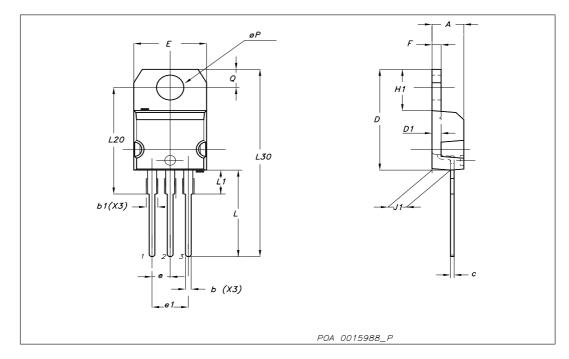
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.



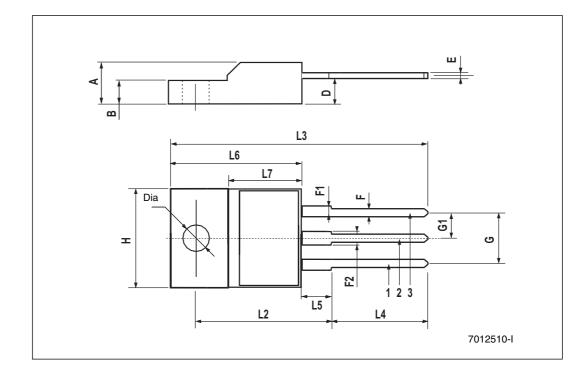
TO-220	mechanical	data
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Dim		mm			inch		
	Min	Тур	Max	Min	Тур	Max	
Α	4.40		4.60	0.173		0.181	
b	0.61		0.88	0.024		0.034	
b1	1.14		1.70	0.044		0.066	
С	0.49		0.70	0.019		0.027	
D	15.25		15.75	0.6		0.62	
D1		1.27			0.050		
E	10		10.40	0.393		0.409	
е	2.40		2.70	0.094		0.106	
e1	4.95		5.15	0.194		0.202	
F	1.23		1.32	0.048		0.051	
H1	6.20		6.60	0.244		0.256	
J1	2.40		2.72	0.094		0.107	
L	13		14	0.511		0.551	
L1	3.50		3.93	0.137		0.154	
L20		16.40			0.645		
L30		28.90			1.137		
ØP	3.75		3.85	0.147		0.151	
Q	2.65		2.95	0.104		0.116	



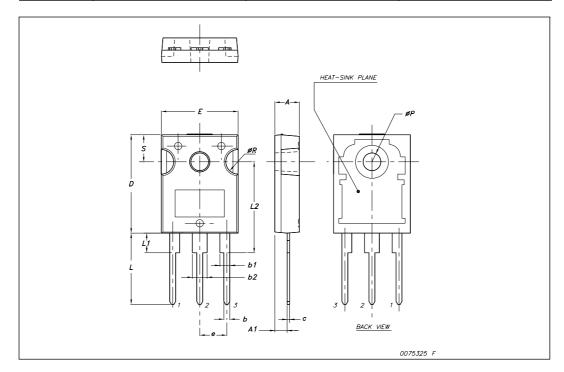


	TO-220FP mechanical data						
Dim.		mm.			inch		
Dim.	Min.	Тур	Max.	Min.	Тур.	Max.	
А	4.40		4.60	0.173		0.181	
В	2.5		2.7	0.098		0.106	
D	2.5		2.75	0.098		0.108	
E	0.45		0.70	0.017		0.027	
F	0.75		1.00	0.030		0.039	
F1	1.15		1.50	0.045		0.067	
F2	1.15		1.50	0.045		0.067	
G	4.95		5.20	0.195		0.204	
G1	2.40		2.70	0.094		0.106	
Н	10		10.40	0.393		0.409	
L2		16			0.630		
L3	28.6		30.6	1.126		1.204	
L4	9.80		10.60	0.385		0.417	
L5	2.9		3.6	0.114		0.141	
L6	15.90		16.40	0.626		0.645	
L7	9		9.30	0.354		0.366	
Dia	3		3.2	0.118		0.126	



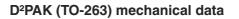


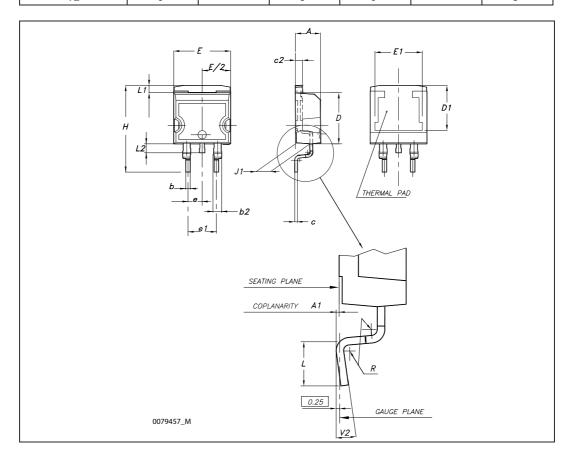
	TO-247 Mechanical data				
Dim.		mm.	1		
	Min.	Тур	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
Е	15.45		15.75		
е		5.45			
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
øP	3.55		3.65		
øR	4.50		5.50		
S		5.50			





Dim		mm			inch		
	Min	Тур	Max	Min	Тур	Мах	
Α	4.40		4.60	0.173		0.181	
A1	0.03		0.23	0.001		0.009	
b	0.70		0.93	0.027		0.037	
b2	1.14		1.70	0.045		0.067	
С	0.45		0.60	0.017		0.024	
c2	1.23		1.36	0.048		0.053	
D	8.95		9.35	0.352		0.368	
D1	7.50			0.295			
E	10		10.40	0.394		0.409	
E1	8.50			0.334			
е		2.54			0.1	İ	
e1	4.88		5.28	0.192		0.208	
Н	15		15.85	0.590		0.624	
J1	2.49		2.69	0.099		0.106	
L	2.29		2.79	0.090		0.110	
L1	1.27		1.40	0.05		0.055	
L2	1.30		1.75	0.051		0.069	
R		0.4			0.016		
V2	0°		8°	0°		8°	

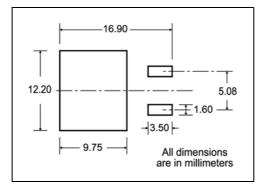




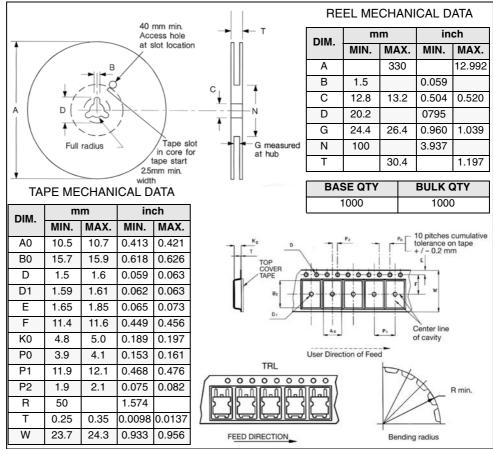


## 5 Packing mechanical data

### D<sup>2</sup>PAK FOOTPRINT



TAPE AND REEL SHIPMENT



\* on sales type



## 6 Revision history

### Table 9.Document revision history

Date	Revision	Changes
20-Sep-2005	4	
05-Oct-2005	5	Inserted ECOPACK <sup>®</sup> indication
29-Feb-2008	6	V <sub>ISO</sub> parameter on <i>Table</i> has been updated
15-Apr-2009	7	Order codes in Table 1: Device summary has been changed



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